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650V 7A N-Channel Super Junction Power MOSFET

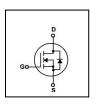
FEATURES

- RDSON≤0.65 Ω @Vgs=10V, Id=3.5A
- Excellent RDS(ON) and Low Gate Charge
- · Fast switching capability
- · Lead free product is acquired

Applications

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

SYMBOL









TO-251L

TO-252

TO-220F

ASSEMBLY MESSAGE

Product Name	Package	Packaging
BXC65R650U	TO-251L	Tube
BXC65R650D	TO-252	Tube/Reel
BXC65R650F	TO-220F	Tube

ABSOLUTE MAXIMUM RATINGS (T_C=25°C unless otherwise noted)

Parameter		Cumbal	Rating		I I mid
		Symbol	BXC65R650U/D	BXC65R650F	Unit
Drain-Source Voltage		V _{DSS}	650		V
Drain Current	Continuous (T _C = 25°C)	- I _D	7		Α
Drain Current	Continuous (T _C = 100°C)		5.6		Α
Drain Current	Pulsed (Note1)	I _{DM}	21		Α
Gate-Source Voltage		V _{GSS}	±30		V
Avalanche Energy	Single Pulse (Note2)	Eas	120		mJ
	Repetitive (Note1)	Ear	0.18		mJ
Avalanche Current (Note1)		I AR	1.2		Α
Peak Diode Recovery dv/dt		dv/dt	5		V/ns
Power Dissipation (Note	T _C =25°C	- P _D	63	32	W
2)	Derate above 25°C		0.5	0.26	W/°C
Maximum Junction Temperature		TJ	150		°C
Storage Temperature Range		T _{STG}	-55 to 150		°C

Note: 1. Limited by maximum junction temperature, maximum duty cycle is 0.75

2. L=4mH, VDD=50V, RG=25 Ω , Starting TJ = 25°C

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THERMAL CHARACTERISTICS

Devementer	Symbol	Ma	l lmi4	
Parameter		BXC65R650U/D	BXC65R650F	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	2	4	°C / W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62	68	°C / W

ELECTRICAL CHARACTERISTICS (T_J=25°C,unless otherwise Noted)

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS	-					
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V, ID=250µA	650			V
Zero Gate Voltage Drain Current	I _{DSS}	VDS=650V, VGS=0V			1	uA
		VDS=520V, TC = 125°C		10		uA
Gate-Body Leakage Current, Forward		VGS=30V			100	nA
Gate-Body Leakage Current, Reverse	I _{GSS}	VGS=-30V			-100	nA
ON CHARACTERISTICS			•			•
Gate Threshold Voltage	V _{GS(TH)}	VDS=VGS, ID=250µA	2.5		4.0	V
Drain-Source On-State Resistance	R _{DS(ON)}	VGS=10V, ID=3.5A		0.56	0.65	Ω
DYNAMIC PARAMETERS			•			•
Input Capacitance	C _{ISS}	VD0 400V/V:00 01/		491		pF
Output Capacitance	Coss	VDS=100V, VGS=0V, f=1.0MHz		23		pF
Reverse Transfer Capacitance	C _{RSS}			0.65		pF
SWITCHING PARAMETERS	•	•	•			
Turn-ON Delay Time	t _{D(ON)}			11.6		ns
Turn-ON Rise Time	t _R	VDD=400V, ID=3.5A, VGS		23		ns
Turn-OFF Delay Time	t _{D(OFF)}	= 10V ,RG=25Ω		53		ns
Turn-OFF Fall-Time	t _F			35.8		ns
Total Gate Charge(Note5)	Q _G	\/DC -520\/ \/CC -40\/ ID		13.3		nC
Gate Source Charge	Q _{GS}	VDS =520V, VGS =10V, ID = =3.5A		2.8		nC
Gate Drain Charge	Q _{GD}			4.7		nC
SOURCE- DRAIN DIODE RATINGS	AND CHARA	ACTERISTICS	•			
Drain-Source Diode Forward Voltage	V _{SD}	IF=3.5A, VGS=0V		0.85		V
Diode Continuous Forward Current	Is				7	Α
Pulsed Drain-Source Current	I _{SM}				21	Α
Reverse Recovery Time	t _{RR}	VR = 50 V, IF = 3.5A		201.4		ns
Reverse Recovery Charge	Q _{RR}	di/dt=100 A/µs		1.3		uC



TYPICAL CHARACTERISTICS

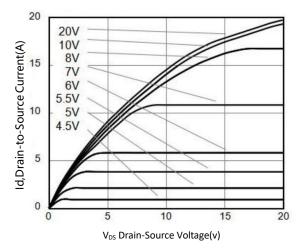


Figure 1. Typical Output Characteristics

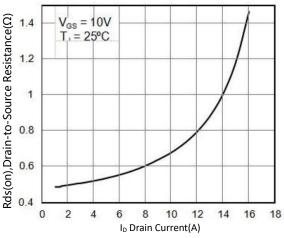


Figure 3. On-Resistance versus Drain Current

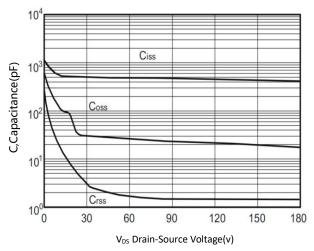


Figure 5. Typical Capacitance versus V_{DS}

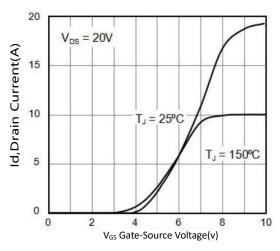


Figure 2. Typical Transfer Characteristics

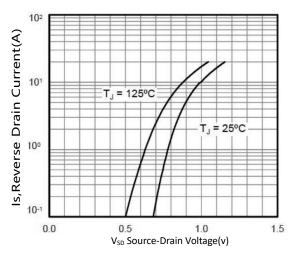


Figure 4. Diode forward voltage versus Current

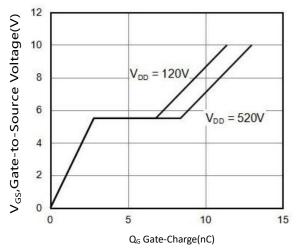


Figure 6. Typical Gate Charge versus V_{GS}



TYPICAL CHARACTERISTICS(Cont.)

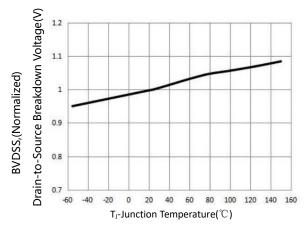


Figure 7. BV_{DSS} Variation with Temperature

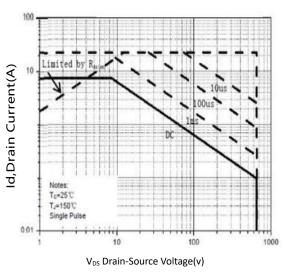


Figure 9. Maximum Safe Operating Area BXC65R650U/D

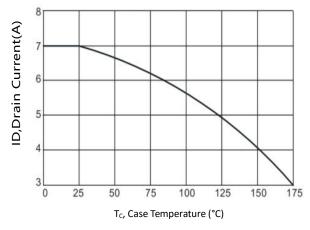


Figure 10. Maximum Continuous Drain Current versus Case Temperature

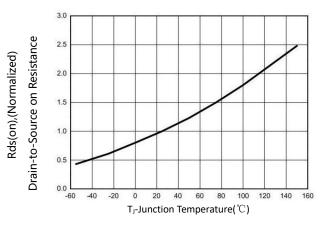


Figure8. On-Resistance Variation with Temperature

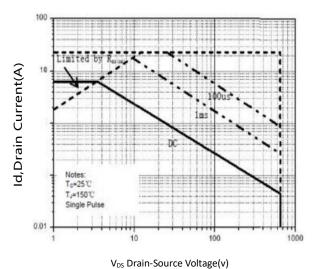
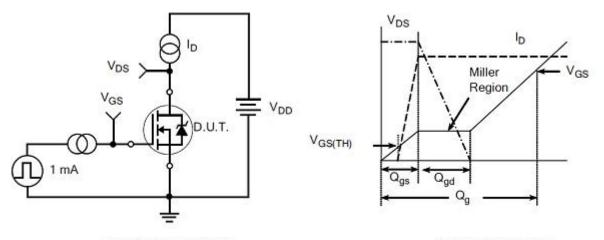
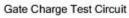


Figure 9. Maximum Safe Operating Area BXC65R650F

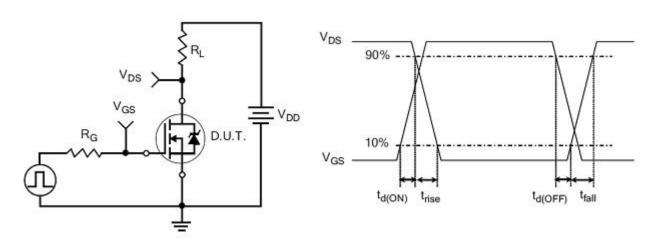


TEST CIRCUITS AND WAVEFORMS





Gate Charge Waveform



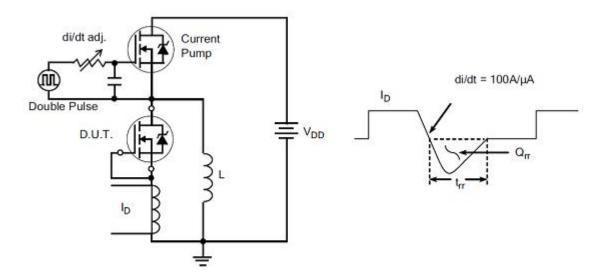
Resistive Switching Test Circuit

Resistive Switching Waveforms

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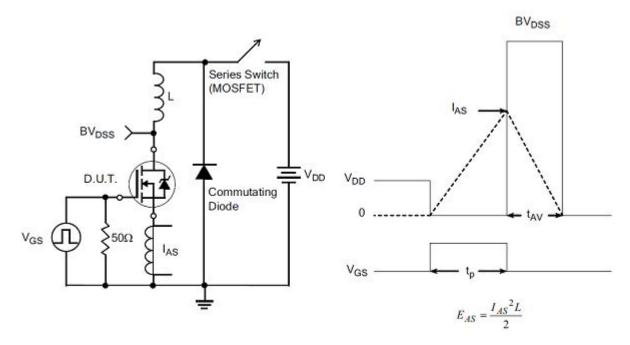


TEST CIRCUITS AND WAVEFORMS(Cont.)



Diode Reverse Recovery Test Circuit

Diode Reverse Recovery Waveform



Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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Revision history

Document revision history

Date	Revision	Changes
3-Sep-2021	1.0	First release
6-Dec-2021	1.1	Update parameter

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